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App	licat	tion	/Co	ntr	ol	No.
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10/014,732

Examiner

TSUKAGOSHI ET AL.

Art Unit

Applicant(s)/Patent under Reexamination

Gelek Topgyal

2621

SEARCHED			
Class	Subclass	Date	Examiner
386	12,33,39,5 2,83,96,98 ,111-112	5/1/2006	GΤ
		- ·	
		188	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		 	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Talk to Thai Tran, Gave Fujinami reference used as secondary reference.	5/1/2006	GТ
Vincent Boccio: Talked about claim interpretation, and presented primary reference	5/2/2006	GТ
Thai Tran and Vincent Boccio: Agreed Aotake ref. was the best primary to use, and to use Fujinami as secondary	5/3/2006	GТ
Huy Nguyen: Asked for reference used for claim 2 rej.	5/3/2006	GT